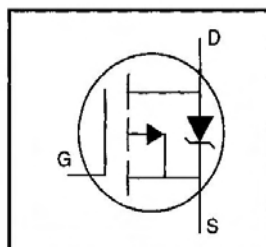


# IRFD9120PbF

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- P-Channel
- 175°C Operating Temperature
- Fast Switching
- Lead-Free



$$V_{DSS} = -100V$$

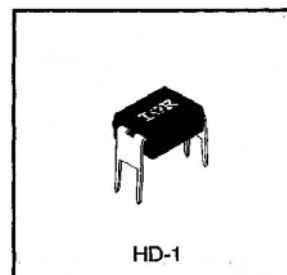
$$R_{DS(on)} = 0.60\Omega$$

$$I_D = -1.0A$$

## Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4-pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1 inch pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 watt.



## Absolute Maximum Ratings

|                           | Parameter                                  | Max.                  | Units |
|---------------------------|--------------------------------------------|-----------------------|-------|
| $I_D @ T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS} @ -10 V$ | -1.0                  | A     |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ -10 V$ | -0.70                 |       |
| $I_{DM}$                  | Pulsed Drain Current ①                     | -8.0                  |       |
| $P_D @ T_C = 25^\circ C$  | Power Dissipation                          | 1.3                   | W     |
|                           | Linear Derating Factor                     | 0.0083                | W/°C  |
| $V_{GS}$                  | Gate-to-Source Voltage                     | $\pm 20$              | V     |
| $E_{AS}$                  | Single Pulse Avalanche Energy ②            | 140                   | mJ    |
| $I_{AR}$                  | Avalanche Current ①                        | -1.0                  | A     |
| $E_{AR}$                  | Repetitive Avalanche Energy ①              | 0.13                  | mJ    |
| dv/dt                     | Peak Diode Recovery dv/dt ③                | -5.5                  | V/ns  |
| $T_J$                     | Operating Junction and                     | -55 to +175           | °C    |
| $T_{STG}$                 | Storage Temperature Range                  |                       |       |
|                           | Soldering Temperature, for 10 seconds      | 300 (1.6mm from case) |       |

## Thermal Resistance

|                 | Parameter           | Min. | Typ. | Max. | Units |
|-----------------|---------------------|------|------|------|-------|
| $R_{\theta JA}$ | Junction-to-Ambient | —    | —    | 120  | °C/W  |

# IRFD9120PbF

International  
IR Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ.  | Max. | Units               | Test Conditions                                                     |
|---------------------------------|--------------------------------------|------|-------|------|---------------------|---------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | -100 | —     | —    | V                   | $V_{GS}=0V$ , $I_D=-250\mu A$                                       |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | -0.10 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D=-1mA$                        |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —     | 0.60 | $\Omega$            | $V_{GS}=-10V$ , $I_D=-0.60A$ ④                                      |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | -2.0 | —     | -4.0 | V                   | $V_{DS}=V_{GS}$ , $I_D=-250\mu A$                                   |
| $g_{fs}$                        | Forward Transconductance             | 0.71 | —     | —    | S                   | $V_{DS}=-50V$ , $I_D=-0.60A$ ④                                      |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | -100 | $\mu A$             | $V_{DS}=-100V$ , $V_{GS}=0V$                                        |
|                                 |                                      | —    | —     | -500 |                     | $V_{DS}=-80V$ , $V_{GS}=0V$ , $T_J=150^\circ\text{C}$               |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | -100 | nA                  | $V_{GS}=-20V$                                                       |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | 100  |                     | $V_{GS}=20V$                                                        |
| $Q_g$                           | Total Gate Charge                    | —    | —     | 18   | nC                  | $I_D=-6.8A$                                                         |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —     | 3.0  |                     | $V_{DS}=-80V$                                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —     | 9.0  |                     | $V_{GS}=-10V$ See Fig. 6 and 13 ④                                   |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 9.6   | —    | ns                  | $V_{DD}=-50V$                                                       |
| $t_r$                           | Rise Time                            | —    | 29    | —    |                     | $I_D=-6.8A$                                                         |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 21    | —    |                     | $R_G=18\Omega$                                                      |
| $t_f$                           | Fall Time                            | —    | 25    | —    |                     | $R_D=7.1\Omega$ See Figure 10 ④                                     |
| $L_D$                           | Internal Drain Inductance            | —    | 4.0   | —    | nH                  | Between lead, 6 mm (0.25in.) from package and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 6.0   | —    |                     |                                                                     |
| $C_{iss}$                       | Input Capacitance                    | —    | 390   | —    | pF                  | $V_{GS}=0V$                                                         |
| $C_{oss}$                       | Output Capacitance                   | —    | 170   | —    |                     | $V_{DS}=-25V$                                                       |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 45    | —    |                     | $f=1.0MHz$ See Figure 5                                             |

## Source-Drain Ratings and Characteristics

|          | Parameter                              | Min.                                                                      | Typ. | Max. | Units   | Test Conditions                                                |
|----------|----------------------------------------|---------------------------------------------------------------------------|------|------|---------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                         | —    | -1.0 | A       | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                         | —    | -8.0 |         |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                         | —    | -6.3 | V       | $T_J=25^\circ\text{C}$ , $I_S=-1.0A$ , $V_{GS}=0V$ ④           |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                         | 98   | 200  | ns      | $T_J=25^\circ\text{C}$ , $I_F=-6.8A$                           |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                         | 0.33 | 0.66 | $\mu C$ | $di/dt=100A/\mu s$ ④                                           |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |         |                                                                |

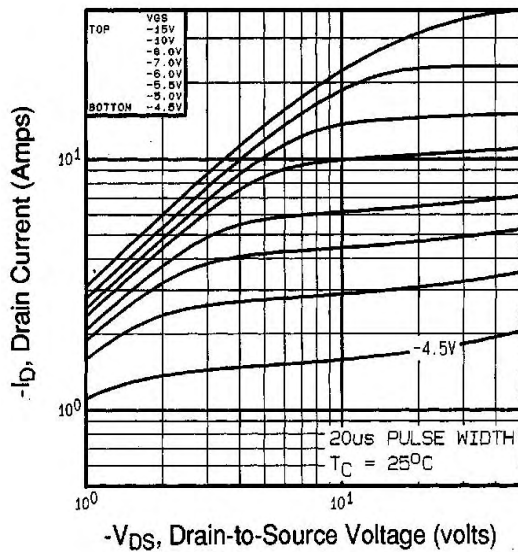
### Notes:

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

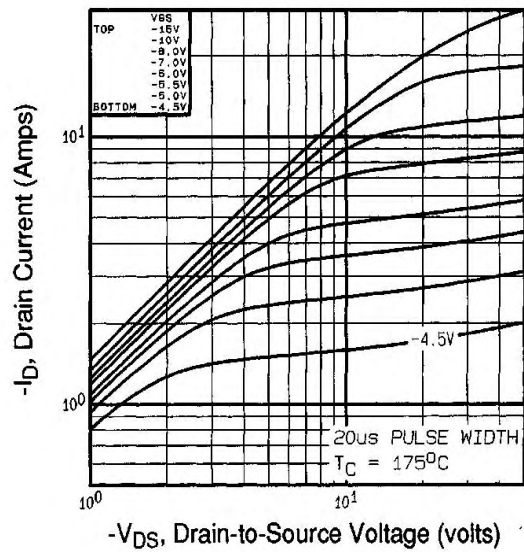
②  $V_{DD}=-25V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=52mH$ ,  $R_G=25\Omega$ ,  $I_{AS}=-2.0A$  (See Figure 12)

③  $I_{SD}\leq 6.8A$ ,  $di/dt\leq 110A/\mu s$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  $T_J\leq 175^\circ\text{C}$

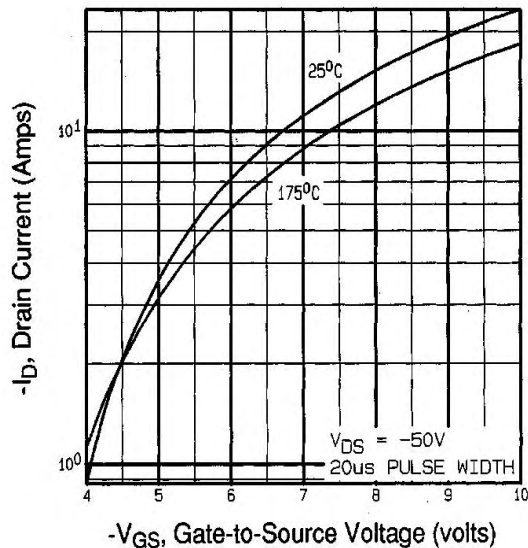
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



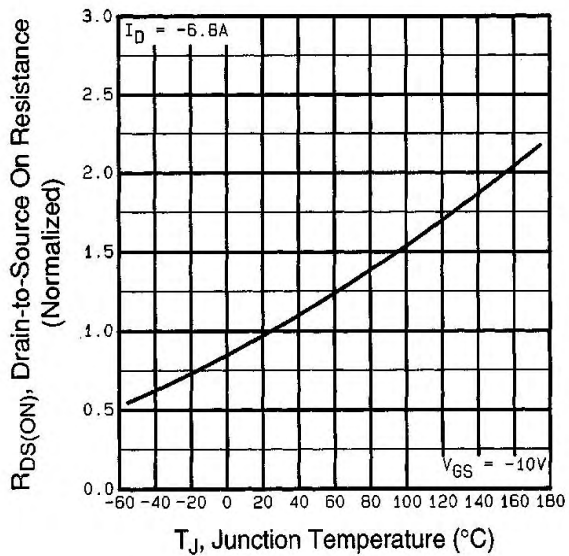
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C = 175^\circ\text{C}$



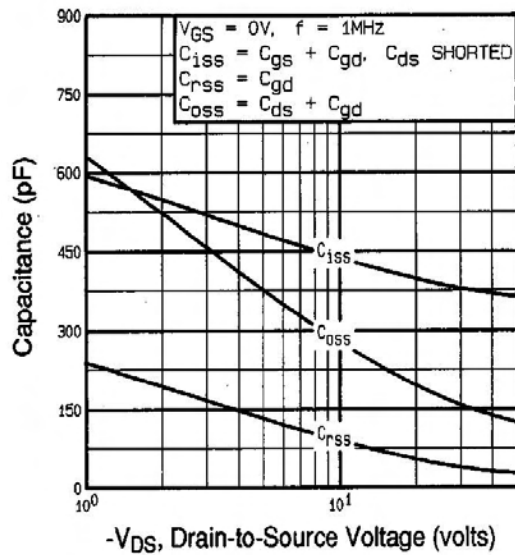
**Fig 3.** Typical Transfer Characteristics



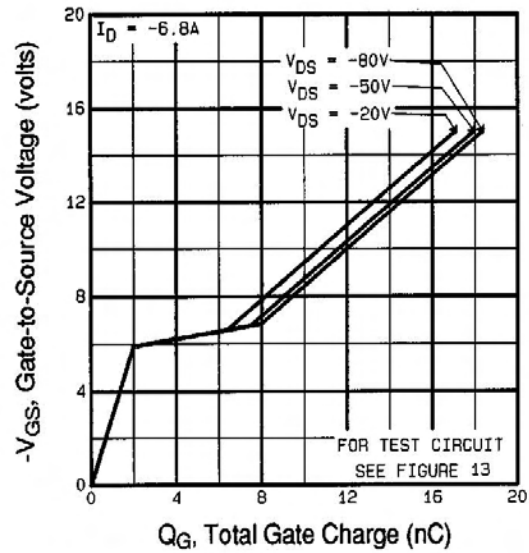
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

# IRFD9120PbF

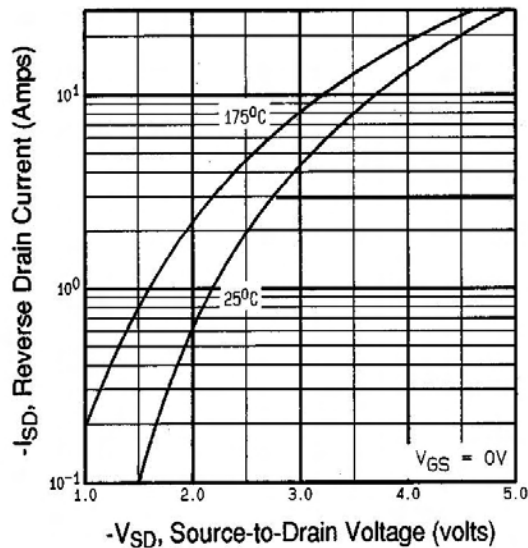
International  
**IR** Rectifier



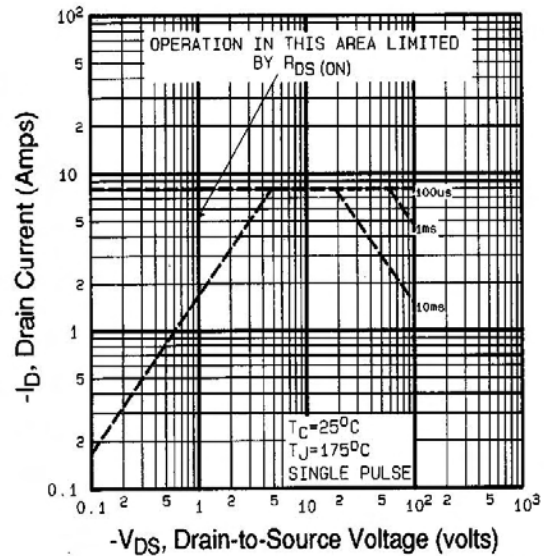
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



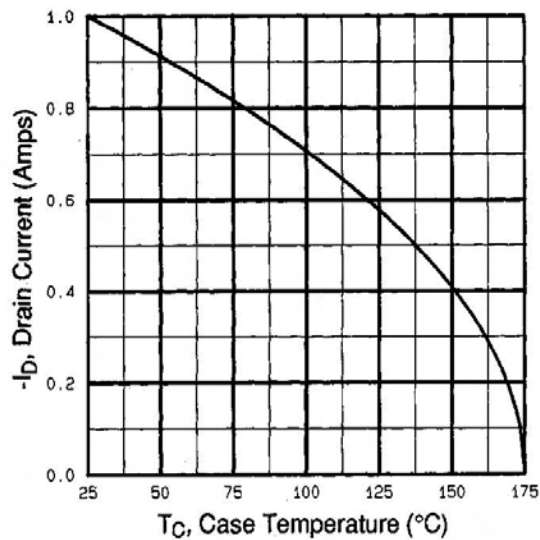
**Fig 7.** Typical Source-Drain Diode Forward Voltage



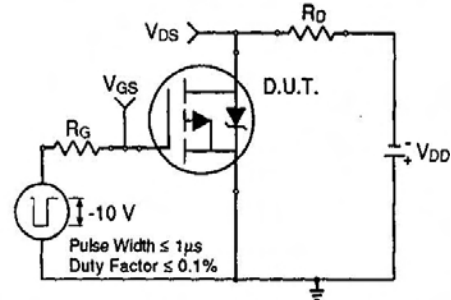
**Fig 8.** Maximum Safe Operating Area



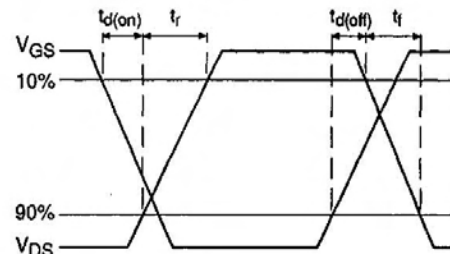
# IRFD9120PbF



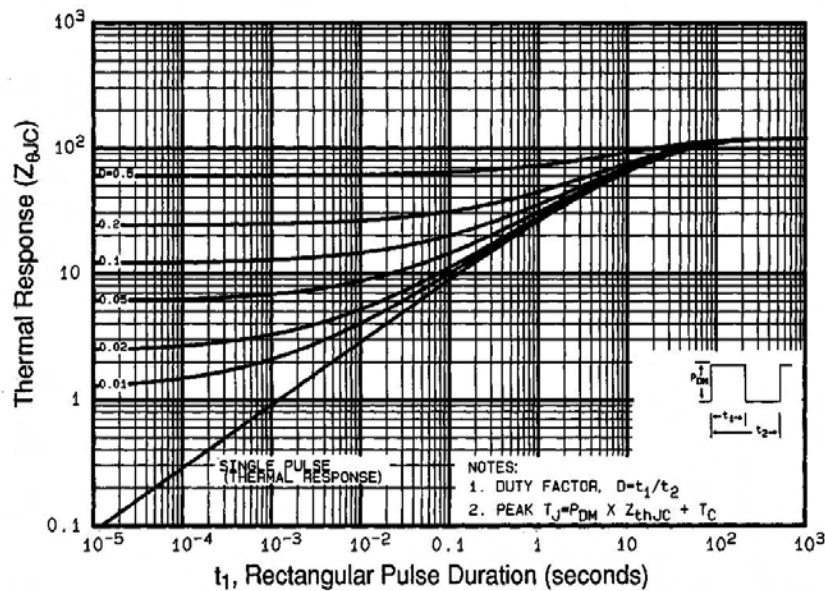
**Fig 9.** Maximum Drain Current Vs. Case Temperature



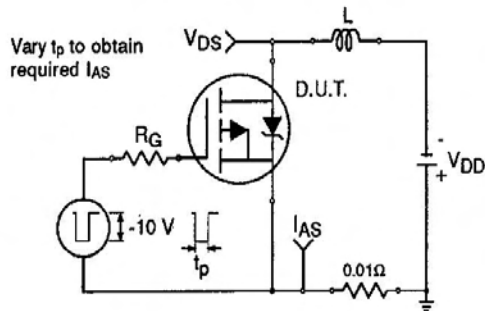
**Fig 10a.** Switching Time Test Circuit



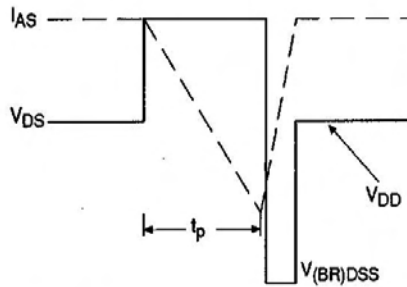
**Fig 10b.** Switching Time Waveforms



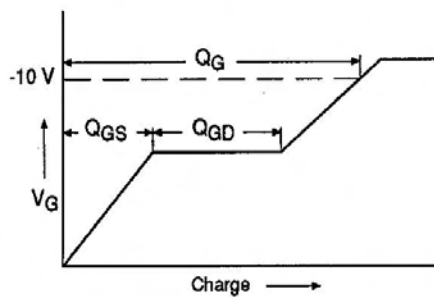
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



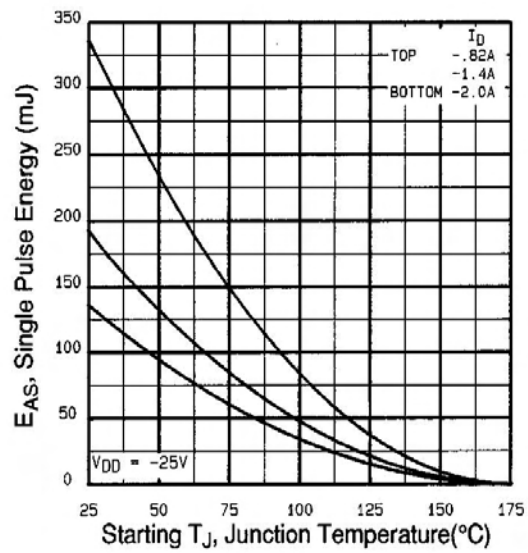
**Fig 12a.** Unclamped Inductive Test Circuit



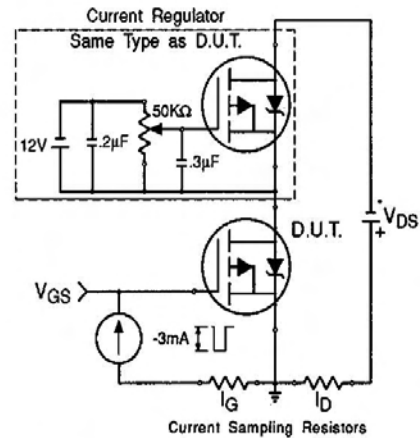
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform

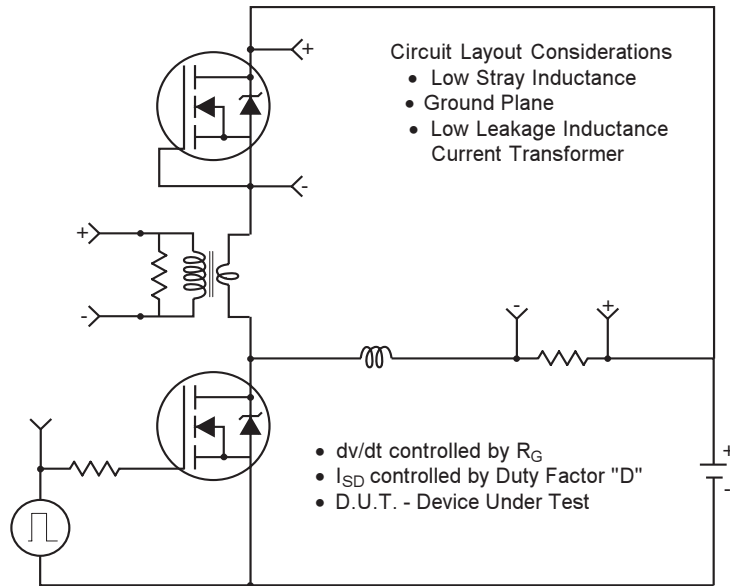


**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



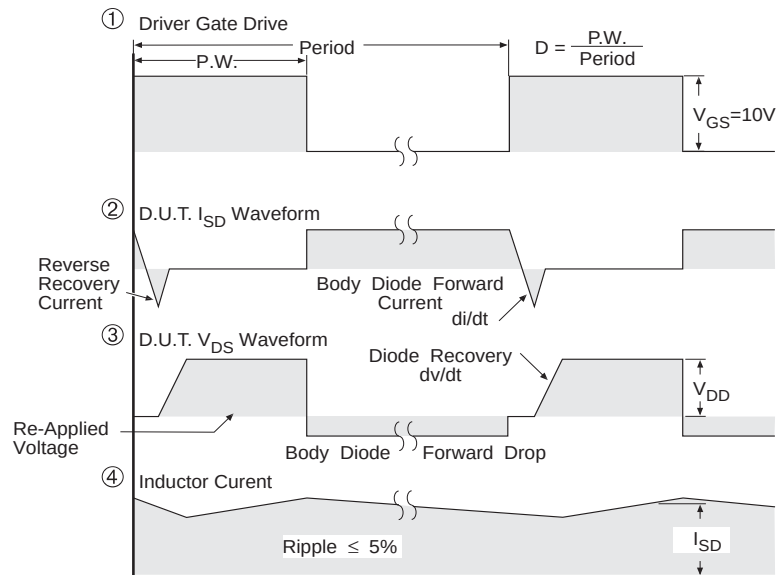
**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity for P-Channel

\*\* Use P-Channel Driver for P-Channel Measurements



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

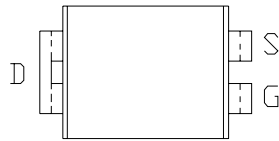
**Fig-14 For P Channel HEXFETS**

# IRFD9120PbF

## Hexdip Package Outline

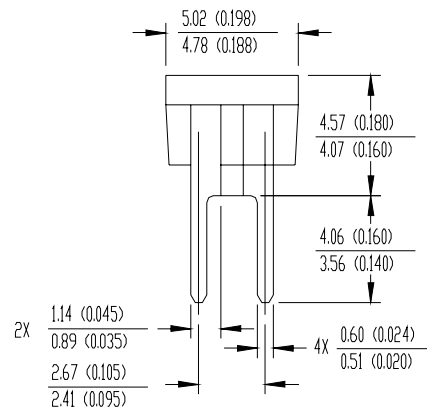
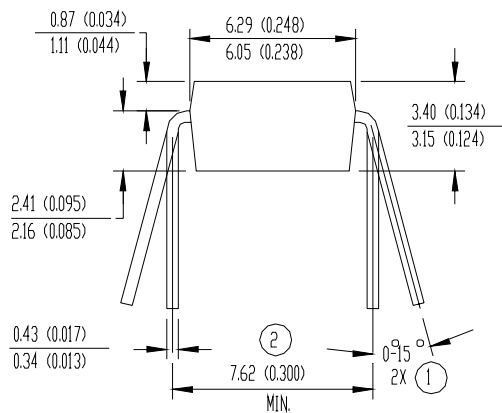
Dimensions are shown in millimeters (inches)

International  
**IR** Rectifier



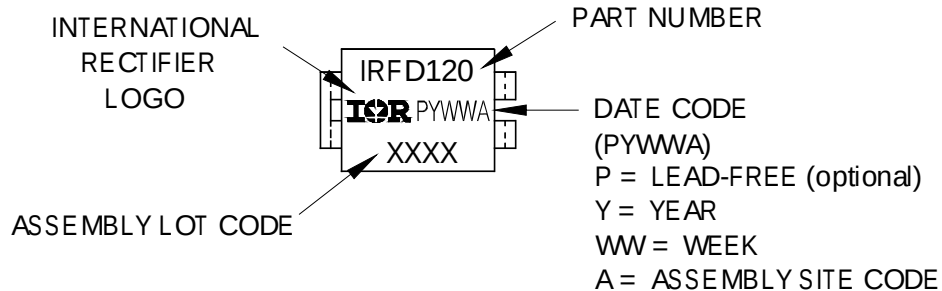
### NOTES:

- ① APPLIES TO SPREAD OF LEADS PRIOR TO INSTALLATION
- ② APPLIES TO INSTALLED LEAD CENTERS
- 3 CONTROLLING DIMENSION: INCH.
- 4 DIMENSIONS ARE SHOWN MILLIMETERS (INCHES).
- 5 CASE STYLE HD-1 (SIMILAR TO JEDEC OUTLINE MO-001AN)
- 6 DIMENSIONS SHOWN ARE BEFORE SOLDER DIP  
SOLDER DIP MAX. + 0.16 (0.006)



## Hexdip Part Marking Information

EXAMPLE: THIS IS AN IRFD120



Data and specifications subject to change without notice.

International  
**IR** Rectifier

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TAC Fax: (310) 252-7903

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